

Inermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	- R _{θJA}	25	40	°C/W			
Maximum Junction-to-Ambient A	Steady-State	ΓθJA	62	75	°C/W			
Maximum Junction-to-Case ^D	Steady-State	$R_{ ext{ heta}JC}$	5	6	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		30			V
I _{DSS} Zer	Zoro Cato Voltago Drain Current	V _{DS} =30V, V _{GS} =0V				1	
	Zero Gate Voltage Drain Current		TJ=55°C			5	μA
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V				±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA		1	1.6	3	V
I _{D(ON)}	On state drain current	V _{GS} =10V, V _{DS} =5V		50			А
R _{DS(ON)} s	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =9A			18	22	
			T _J =125°C		26	32	mΩ
		V _{GS} =4.5V, I _D =5A			27	34	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =9A			24		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.75	1	V
I _S	Maximum Body-Diode Continuous Current					4.3	А
DYNAMI	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			621	820	pF
C _{oss}	Output Capacitance				118		рF
C _{rss}	Reverse Transfer Capacitance				85		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			0.8	1.5	Ω
SWITCH	NG PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =4.5V, V _{DS} =15V, I _D =9A			6	8	nC
Q_{gs}	Gate Source Charge				2.1		nC
Q_{gd}	Gate Drain Charge				3		nC
t _{D(on)}	Turn-On DelayTime				4.5		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.7 Ω , R_{GEN} =3 Ω			3.1		ns
t _{D(off)}	Turn-Off DelayTime				15.1		ns
t _f	Turn-Off Fall Time				2.7		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =9A, dl/dt=100A/μs			15.5	20	ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =9A, dl/dt=100A/μs		7.1		nC	

A: The value of $R_{\theta JA}$ is measured with the device in a still air environment with $T_A = 25^{\circ}$ C. The power dissipation P_{DSM} and current rating I_{DSM} are based on $T_{J(MAX)} = 150^{\circ}$ C, using t ≤ 10 s junction-to-ambient thermal resistance.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.

D. The $R_{\rm \theta JA}$ is the sum of the thermal impedence from junction to case R $_{\rm \theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

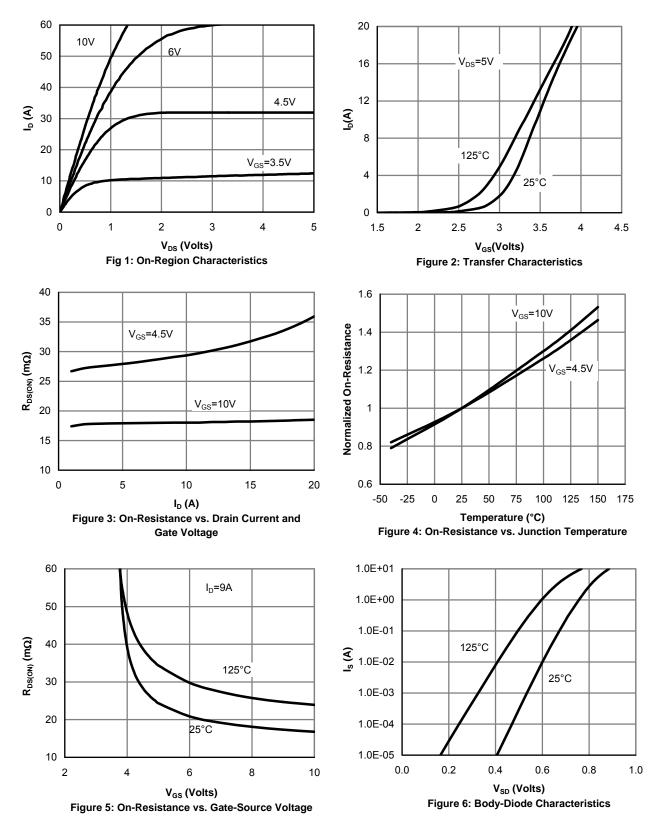
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse rating.

G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}C$.

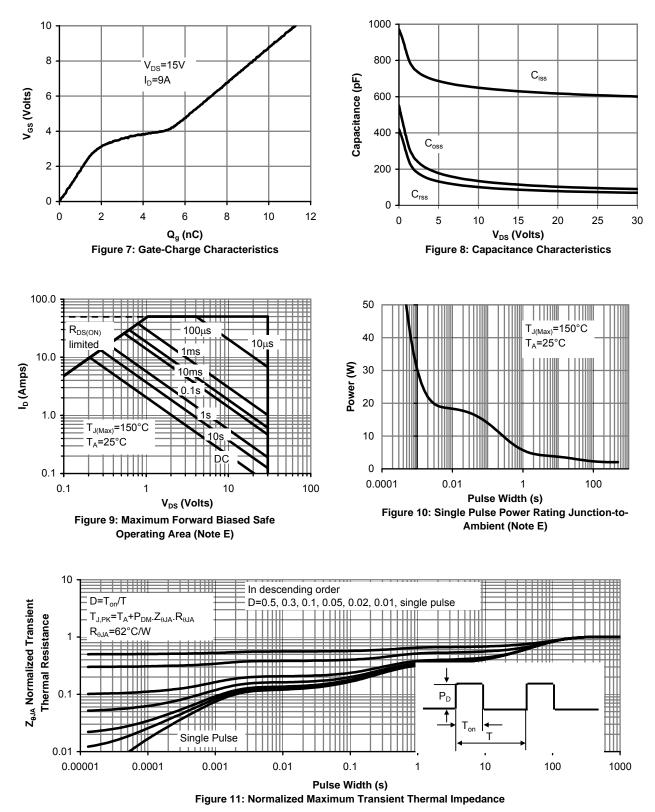
H. The maximum current rating is limited by bond-wires.

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